

9/22/03

Sheet 1 of 1

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 116898		APPLICATION NO. New U.S. Application	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Tsuyoshi KANEKO			
				FILING DATE September 22, 2003		GROUP	

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	1.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
DN	1.	6,144,682	11/7/2000	SUN		

FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)						

EXAMINER <div style="text-align: center;"> </div>	DATE CONSIDERED <div style="text-align: center;"> </div>
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Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: September 22, 2003



Sheet 1 of 1

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 116898		APPLICATION NO. 10/665,447	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Tsuyoshi KANEKO			
				FILING DATE September 22, 2003		GROUP 2828	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
PN	1.	US 2002/0127754 A1	9/12/2002	KANEKO et al.			
PN	2.	US 6,185,241 B1	2/6/2001	SUN			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
PN	3.	EP 1 130 720 A1	9/5/2001	EUROPE			
	4.	WO 02/45217 A2	6/6/2002	WIPO			
PN	5.	JP A 63-274187 w/abstract	11/11/1988	JAPAN			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
PN	6.	R. A. Morgan et al.; "Hybrid Dielectric/AlGaAs Mirror Spatially Filtered Vertical Cavity Top-Surface Emitting Laser"; Applied Physics Letters; Vol 66, No. 15; March 1995; pp 1157-1159					
PN	7.	R. R. Schaefer; "Method for Fabricating Polyimide Films"; XP-000806741; IBM Technical Disclosure Bulletin; Vol. 25, No. 3A; August 1982; pp 1162-1163					
EXAMINER				DATE CONSIDERED 10/13/05			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: February 10, 2004

Sheet 1 of 1

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 116898		APPLICATION NO. 10/665,447	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT Tsuyoshi KANEKO			
				FILING DATE September 22, 2003		GROUP 2828	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	
DW	1.	JP A 2001-284727 w/abstract & transl.	10/12/2001	JAPAN			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			
				10/13/05			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: April 28, 2005

Sheet 1 of 1Form PTO-1449
(REV. 8-83)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
116898APPLICATION NO.
10/665,447

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT
Tsuyoshi KANEKOFILING DATE
September 22, 2003GROUP
2828

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
PN	1.	US 6,590,917 B2	7/8/2003	NAKAYAMA et al.		

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
PN	2.	JP A 2001-284722 w/abstract & transl.	10/12/2001	JAPAN		
	3.	JP A 2001-156395 w/abstract & transl.	6/8/2001	JAPAN		
	4.	JP A 2000-67449 w/abstract & transl.	3/3/2000	JAPAN		
	5.	JP A 2000-22271 w/abstract & transl.	1/21/2000	JAPAN		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

DATE CONSIDERED

Examiner:

Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: May 23, 2005